



HIGH SPEED QUAD DIGITAL ISOLATORS

Check for Samples: [ISO7240CF](#), [ISO7240C](#), [ISO7240M](#), [ISO7241C](#), [ISO7241M](#), [ISO7242C](#), [ISO7242M](#)

FEATURES

- Selectable Failsafe Output (ISO7240CF)
- 25 and 150-Mbps Signaling Rate Options
 - Low Channel-to-Channel Output Skew; 1 ns Max
 - Low Pulse-Width Distortion (PWD); 2 ns Max
 - Low Jitter Content; 1 ns Typ at 150 Mbps
- Typical 25-Year Life at Rated Working Voltage (see application note [SLLA197](#) and [Figure 17](#))
- 4000-V_{peak} Isolation, 560-V_{peak} V_{IORM}
 - UL 1577, IEC 60747-5-2 (VDE 0884, Rev 2), IEC 61010-1, IEC 60950-1 and CSA Approved

- 4 kV ESD Protection
- Operate With 3.3-V or 5-V Supplies
- High Electromagnetic Immunity (see application report [SLLA181](#))
- –40°C to 125°C Operating Range

APPLICATIONS

- Industrial Fieldbus
- Computer Peripheral Interface
- Servo Control Interface
- Data Acquisition

DESCRIPTION

The ISO7240, ISO7241 and ISO7242 are quad-channel digital isolators with multiple channel configurations and output enable functions. These devices have logic input and output buffers separated by TI's silicon dioxide (SiO₂) isolation barrier. Used in conjunction with isolated power supplies, these devices block high voltage, isolate grounds, and prevent noise currents from entering the local ground and interfering with or damaging sensitive circuitry.

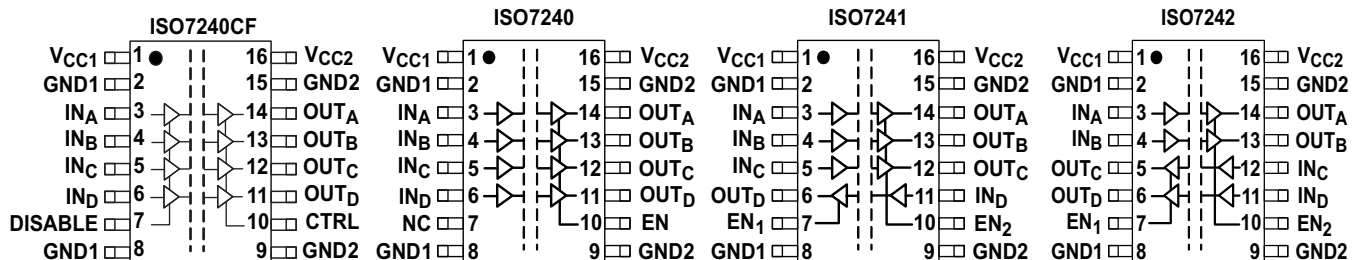
The ISO7240 has all four channels in the same direction while the ISO7241 has three channels the same direction and one channel in opposition. The ISO7242 has two channels in each direction.

The C option devices have TTL input thresholds and a noise-filter at the input that prevents transient pulses from being passed to the output of the device. The M option devices have CMOS V_{cc}/2 input thresholds and do not have the input noise-filter or the additional propagation delay.

The ISO7240CF has an input disable function on pin 7, and a selectable high or low failsafe-output function with the CTRL pin (pin 10). The failsafe-output is a logic high when a logic-high is placed on the CTRL pin or it is left unconnected. If a logic-low signal is applied to the CTRL pin, the failsafe-output becomes a logic-low output state. The ISO7240CF input disable function prevents data from being passed across the isolation barrier to the output. When the inputs are disabled, the outputs are set by the CTRL pin.

These devices may be powered from either 3.3-V or 5-V supplies on either side in any 3.3-V / 3.3-V, 5-V / 5-V, 5-V / 3.3-V, or 3.3-V / 5-V combination. Note that the signal input pins are 5-V tolerant regardless of the voltage supply level being used.

These devices are characterized for operation over the ambient temperature range of –40°C to 125°C.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

Table 1. Device Function Table ISO724x ⁽¹⁾

INPUT V _{CC}	OUTPUT V _{CC}	INPUT (IN)	OUTPUT ENABLE (EN)	OUTPUT (OUT)
PU	PU	H	H or Open	H
		L	H or Open	L
		X	L	Z
		Open	H or Open	H
PD	PU	X	H or Open	H
PD	PU	X	L	Z

(1) PU = Powered Up; PD = Powered Down ; X = Irrelevant; H = High Level; L = Low Level

Table 2. ISO7240CF Function Table

V _{CC1}	V _{CC2}	DATA INPUT (IN)	DISABLE INPUT (DISABLE)	FAILSAFE CONTROL INPUT (CTRL)	DATA OUTPUT (OUT)
PU	PU	H	L or Open	X	H
PU	PU	L	L or Open	X	L
X	PU	X	H	H or Open	H
X	PU	X	H	L	L
PD	PU	X	X	H or Open	H
PD	PU	X	X	L	L

AVAILABLE OPTIONS

PRODUCT	SIGNALING RATE	INPUT THRESHOLD	CHANNEL CONFIGURATION	MARKED AS	ORDERING NUMBER ⁽¹⁾
ISO7240CDW	25 Mbps	~1.5 V (TTL) (CMOS compatible)	4/0	ISO7240C	ISO7240CDW (rail)
					ISO7240CDWR (reel)
ISO7240CF	25 Mbps	~1.5 V (TTL) (CMOS compatible)		ISO7240CF	ISO7240CFDW (rail)
					ISO7240CFDWR (reel)
ISO7240MDW	150 Mbps	V _{cc} /2 (CMOS)		ISO7240M	ISO7240MDW (rail)
					ISO7240MDWR (reel)
ISO7241CDW	25 Mbps	~1.5 V (TTL) (CMOS compatible)	3/1	ISO7241C	ISO7241CDW (rail)
					ISO7241CDWR (reel)
ISO7241MDW	150 Mbps	V _{cc} /2 (CMOS)		ISO7241M	ISO7241MDW (rail)
					ISO7241MDWR (reel)
ISO7242CDW	25 Mbps	~1.5 V (TTL) (CMOS compatible)	2/2	ISO7242C	ISO7242CDW (rail)
					ISO7242CDWR (reel)
ISO7242MDW	150 Mbps	V _{cc} /2 (CMOS)		ISO7242M	ISO7242MDW (rail)
					ISO7242MDWR (reel)

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.

ABSOLUTE MAXIMUM RATINGS⁽¹⁾

				VALUE	UNIT	
V _{CC}	Supply voltage ⁽²⁾ , V _{CC1} , V _{CC2}			−0.5 to 6	V	
V _I	Voltage at IN, OUT, EN, DISABLE, CTRL			−0.5 to 6	V	
I _O	Output current			±15	mA	
ESD	Electrostatic discharge	Human Body Model	JEDEC Standard 22, Test Method A114-C.01	All pins	±4	kV
		Field-Induced-Charged Device Model	JEDEC Standard 22, Test Method C101		±1	
		Machine Model	ANSI/ESDS5.2-1996		±200	V
T _J	Maximum junction temperature			170	°C	

- (1) Stresses beyond those listed under *absolute maximum ratings* may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under *recommended operating conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values are with respect to network ground terminal and are peak voltage values.

RECOMMENDED OPERATING CONDITIONS

				MIN	TYP	MAX	UNIT
V _{CC}	Supply voltage ⁽¹⁾ , V _{CC1} , V _{CC2}			3.15		5.5	V
I _{OH}	High-level output current					4	mA
I _{OL}	Low-level output current			–4			mA
t _{ui}	Input pulse width	ISO724xC		40			ns
		ISO724xM		6.67	5		
1/t _{ui}	Signaling rate	ISO724xC		0	30 ⁽²⁾	25	Mbps
		ISO724xM		0	200 ⁽²⁾	150	
V _{IH}	High-level input voltage (IN)			0.7 V _{CC}		V _{CC}	V
V _{IL}	Low-level input voltage (IN)			0		0.3 V _{CC}	V
V _{IH}	High-level input voltage (IN, DISABLE, CTRL, EN)			2		V _{CC}	V
V _{IL}	Low-level input voltage (IN, DISABLE, CTRL, EN)			0		0.8	V
T _J	Junction temperature					150	°C
H	External magnetic field-strength immunity per IEC 61000-4-8 and IEC 61000-4-9 certification					1000	A/m

- (1) For the 5-V operation, V_{CC1} or V_{CC2} is specified from 4.5 V to 5.5 V.
For the 3-V operation, V_{CC1} or V_{CC2} is specified from 3.15 V to 3.6 V.
- (2) Typical value at room temperature and well-regulated power supply.

IEC 60747-5-2 INSULATION CHARACTERISTICS⁽¹⁾

over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS	SPECIFICATIONS	UNIT
V _{IORM}	Maximum working insulation voltage		560	V
V _{PR}	Input to output test voltage	After Input/Output Safety Test Subgroup 2/3 V _{PR} = V _{IORM} × 1.2, t = 10 s, Partial discharge < 5 pC	672	V
		Method a, V _{PR} = V _{IORM} × 1.6, Type and sample test with t = 10 s, Partial discharge < 5 pC	896	V
		Method b1, V _{PR} = V _{IORM} × 1.875, 100 % Production test with t = 1 s, Partial discharge < 5 pC	1050	V
V _{IOTM}	Transient overvoltage	t = 60 s	4000	V
R _S	Insulation resistance	V _{IO} = 500 V at T _S	>10 ⁹	Ω
	Pollution degree		2	

- (1) Climatic Classification 40/125/21

ELECTRICAL CHARACTERISTICS: V_{CC1} and V_{CC2} at 5-V⁽¹⁾ OPERATION

, over recommended operating conditions (unless otherwise noted)

PARAMETER			TEST CONDITIONS	MIN	TYP	MAX	UNIT
SUPPLY CURRENT							
I _{CC1}	ISO7240C/M	Quiescent	V _I = V _{CC} or 0 V, All channels, no load, EN ₂ at 3 V		1	3	mA
		25 Mbps			7	10.5	
	ISO7241C/M	Quiescent	V _I = V _{CC} or 0 V, All channels, no load, EN ₁ at 3 V, EN ₂ at 3 V		6.5	11	mA
		25 Mbps			12	18	
	ISO7242C/M	Quiescent	V _I = V _{CC} or 0 V, All channels, no load, EN ₁ at 3 V, EN ₂ at 3 V		10	16	mA
		25 Mbps			15	24	
I _{CC2}	ISO7240C/M	Quiescent	V _I = V _{CC} or 0 V, All channels, no load, EN ₂ at 3 V		15	22	mA
		25 Mbps			17	25	
	ISO7241C/M	Quiescent	V _I = V _{CC} or 0 V, All channels, no load, EN ₁ at 3 V, EN ₂ at 3 V		13	20	mA
		25 Mbps			18	28	
	ISO7242C/M	Quiescent	V _I = V _{CC} or 0 V, All channels, no load, EN ₁ at 3 V, EN ₂ at 3 V		10	16	mA
		25 Mbps			15	24	
ELECTRICAL CHARACTERISTICS							
I _{OFF}	Sleep mode output current		EN at 0 V, Single channel		0		μA
V _{OH}	High-level output voltage		I _{OH} = −4 mA, See Figure 1	V _{CC} − 0.8			V
			I _{OH} = −20 μA, See Figure 1	V _{CC} − 0.1			
V _{OL}	Low-level output voltage		I _{OL} = 4 mA, See Figure 1			0.4	V
			I _{OL} = 20 μA, See Figure 1			0.1	
V _{I(HYS)}	Input voltage hysteresis			150			mV
I _{IH}	High-level input current		IN from 0 V to V _{CC}			10	μA
I _{IL}	Low-level input current			−10			
C _I	Input capacitance to ground		IN at V _{CC} , V _I = 0.4 sin (4E6πt)	2			pF
CMTI	Common-mode transient immunity		V _I = V _{CC} or 0 V, See Figure 5	25	50		kV/μs

- (1) For the 5-V operation, V_{CC1} or V_{CC2} is specified from 4.5 V to 5.5 V.
For the 3-V operation, V_{CC1} or V_{CC2} is specified from 3.15 V to 3.6 V.

SWITCHING CHARACTERISTICS: V_{CC1} and V_{CC2} at 5-V OPERATION

over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH} , t_{PHL}	Propagation delay	See Figure 1	18		42	ns
PWD	Pulse-width distortion ⁽¹⁾ $ t_{PHL} - t_{PLH} $				2.5	
t_{PLH} , t_{PHL}	Propagation delay		10		23	ns
PWD	Pulse-width distortion ⁽¹⁾ $ t_{PHL} - t_{PLH} $			1	2	
$t_{sk(pp)}$	Part-to-part skew ⁽²⁾	ISO724xC			8	ns
		ISO724xM		0	3	
$t_{sk(o)}$	Channel-to-channel output skew ⁽³⁾	ISO724xC			2	ns
		ISO724xM		0	1	
t_r	Output signal rise time	See Figure 1		2		ns
t_f	Output signal fall time			2		
t_{PHZ}	Propagation delay, high-level-to-high-impedance output	See Figure 2		15	20	ns
t_{PZH}	Propagation delay, high-impedance-to-high-level output			15	20	
t_{PLZ}	Propagation delay, low-level-to-high-impedance output			15	20	
t_{PZL}	Propagation delay, high-impedance-to-low-level output			15	20	
t_{fs}	Failsafe output delay time from input power loss	See Figure 3		12		μ s
t_{wake}	Wake time from input disable	See Figure 4		15		μ s
$t_{jit(pp)}$	Peak-to-peak eye-pattern jitter	ISO724xM 150 Mbps NRZ data input, Same polarity input on all channels, See Figure 6		1		ns

- (1) Also referred to as pulse skew.
(2) $t_{sk(pp)}$ is the magnitude of the difference in propagation delay times between any specified terminals of two devices when both devices operate with the same supply voltages, at the same temperature, and have identical packages and test circuits.
(3) $t_{sk(o)}$ is the skew between specified outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical specified loads.

ELECTRICAL CHARACTERISTICS: V_{CC1} at 5-V, V_{CC2} at 3.3-V⁽¹⁾ OPERATION

over recommended operating conditions (unless otherwise noted)

PARAMETER			TEST CONDITIONS		MIN	TYP	MAX	UNIT
SUPPLY CURRENT								
I _{CC1}	ISO7240C/M	Quiescent	V _I = V _{CC} or 0 V, All channels, no load, EN ₂ at 3 V		1	3	mA	
		25 Mbps			7	10.5		
	ISO7241C/M	Quiescent	V _I = V _{CC} or 0 V, All channels, no load, EN ₁ at 3 V, EN ₂ at 3 V		6.5	11	mA	
		25 Mbps			12	18		
	ISO7242C/M	Quiescent	V _I = V _{CC} or 0 V, All channels, no load, EN ₁ at 3 V, EN ₂ at 3 V		10	16	mA	
		25 Mbps			15	24		
I _{CC2}	ISO7240C/M	Quiescent	V _I = V _{CC} or 0 V, All channels, no load, EN ₂ at 3 V		9.5	15	mA	
		25 Mbps			10.5	17		
	ISO7241C/M	Quiescent	V _I = V _{CC} or 0 V, All channels, no load, EN ₁ at 3 V, EN ₂ at 3 V		8	13	mA	
		25 Mbps			11.5	18		
	ISO7242C/M	Quiescent	V _I = V _{CC} or 0 V, All channels, no load, EN ₁ at 3 V, EN ₂ at 3 V		6	10	mA	
		25 Mbps			9	14		
ELECTRICAL CHARACTERISTICS								
I _{OFF}	Sleep mode output current		EN at 0 V, Single channel		0		μA	
V _{OH}	High-level output voltage		I _{OH} = −4 mA, See Figure 1	ISO7240	V _{CC} − 0.4		V	
				ISO724x (5-V side)	V _{CC} − 0.8			
			I _{OH} = −20 μA, See Figure 1		V _{CC} − 0.1			
V _{OL}	Low-level output voltage		I _{OL} = 4 mA, See Figure 1		0.4		V	
			I _{OL} = 20 μA, See Figure 1		0.1			
V _{I(HYS)}	Input voltage hysteresis				150		mV	
I _{IH}	High-level input current		IN from 0 V to V _{CC}		10		μA	
I _{IL}	Low-level input current				−10			
C _I	Input capacitance to ground		IN at V _{CC} , V _I = 0.4 sin (4E6πt)		2		pF	
CMTI	Common-mode transient immunity		V _I = V _{CC} or 0 V, See Figure 5		25	50	kV/μs	

- (1) For the 5-V operation, V_{CC1} or V_{CC2} is specified from 4.5 V to 5.5 V.
For the 3-V operation, V_{CC1} or V_{CC2} is specified from 3.15 V to 3.6 V.

SWITCHING CHARACTERISTICS: V_{CC1} at 5-V, V_{CC2} at 3.3-V OPERATION

over recommended operating conditions (unless otherwise noted)

PARAMETER			TEST CONDITIONS	MIN	TYP	MAX	UNIT		
t _{PLH} , t _{PHL}	Propagation delay	ISO724xC	See Figure 1	20		50	ns		
PWD	Pulse-width distortion ⁽¹⁾ t _{PHL} – t _{PLH}					3			
t _{PLH} , t _{PHL}	Propagation delay	ISO724xM		12		29	ns		
PWD	Pulse-width distortion ⁽¹⁾ t _{PHL} – t _{PLH}					1		2	
t _{sk(pp)}	Part-to-part skew ⁽²⁾	ISO724xC				10	ns		
		ISO724xM				0		5	
t _{sk(o)}	Channel-to-channel output skew ⁽³⁾	ISO724xC				3	ns		
		ISO724xM				0		1	
t _r	Output signal rise time	See Figure 1				2	ns		
t _f	Output signal fall time					2			
t _{PHZ}	Propagation delay, high-level-to-high-impedance output	See Figure 2				15	20	ns	
t _{PZH}	Propagation delay, high-impedance-to-high-level output					15			20
t _{PLZ}	Propagation delay, low-level-to-high-impedance output					15			20
t _{PZL}	Propagation delay, high-impedance-to-low-level output					15			20
t _{fs}	Failsafe output delay time from input power loss	See Figure 3				18		μs	
t _{wake}	Wake time from input disable	See Figure 4				15		μs	
t _{jit(pp)}	Peak-to-peak eye-pattern jitter	ISO724xM	150 Mbps PRBS NRZ data input, Same polarity input on all channels, See Figure 6			1		ns	

(1) Also known as pulse skew

(2) $t_{sk(pp)}$ is the magnitude of the difference in propagation delay times between any specified terminals of two devices when both devices operate with the same supply voltages, at the same temperature, and have identical packages and test circuits.

(3) $t_{sk(o)}$ is the skew between specified outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical specified loads.

ELECTRICAL CHARACTERISTICS: V_{CC1} at 3.3-V, V_{CC2} at 5-V⁽¹⁾ OPERATION

over recommended operating conditions (unless otherwise noted)

PARAMETER			TEST CONDITIONS		MIN	TYP	MAX	UNIT
SUPPLY CURRENT								
I _{CC1}	ISO7240C/M	Quiescent	V _I = V _{CC} or 0 V, All channels, no load, EN ₂ at 3 V			0.5	1	mA
		25 Mbps				3	5	
	ISO7241C/M	Quiescent	V _I = V _{CC} or 0 V, All channels, no load, EN ₁ at 3 V, EN ₂ at 3 V			4	7	mA
		25 Mbps				6.5	11	
	ISO724C/M	Quiescent	V _I = V _{CC} or 0 V, All channels, no load, EN ₁ at 3 V, EN ₂ at 3 V			6	10	mA
		25 Mbps				9	14	
I _{CC2}	ISO7240C/M	Quiescent	V _I = V _{CC} or 0 V, All channels, no load, EN ₂ at 3 V			15	22	mA
		25 Mbps				17	25	
	ISO7241C/M	Quiescent	V _I = V _{CC} or 0 V, All channels, no load, EN ₁ at 3 V, EN ₂ at 3 V			13	20	mA
		25 Mbps				18	28	
	ISO7242C/M	Quiescent	V _I = V _{CC} or 0 V, All channels, no load, EN ₁ at 3 V, EN ₂ at 3 V			10	16	mA
		25 Mbps				15	24	
ELECTRICAL CHARACTERISTICS								
I _{OFF}	Sleep mode output current		EN at 0 V, Single channel			0		μA
V _{OH}	High-level output voltage		I _{OH} = −4 mA, See Figure 1	ISO7240	V _{CC} − 0.4		V	
				ISO724x (5-V side)	V _{CC} − 0.8			
			I _{OH} = −20 μA, See Figure 1			V _{CC} − 0.1		
V _{OL}	Low-level output voltage		I _{OL} = 4 mA, See Figure 1			0.4		V
			I _{OL} = 20 μA, See Figure 1			0.1		
V _{I(HYS)}	Input voltage hysteresis					150		mV
I _{IH}	High-level input current		IN from 0 V to V _{CC}			10		μA
I _{IL}	Low-level input current					−10		
C _I	Input capacitance to ground		IN at V _{CC} , V _I = 0.4 sin (4E6πt)			2		pF
CMTI	Common-mode transient immunity		V _I = V _{CC} or 0 V, See Figure 5			25	50	kV/μs

- (1) For the 5-V operation, V_{CC1} or V_{CC2} is specified from 4.5 V to 5.5 V.
For the 3-V operation, V_{CC1} or V_{CC2} is specified from 3.15 V to 3.6 V.

SWITCHING CHARACTERISTICS: V_{CC1} at 3.3-V and V_{CC2} at 5-V OPERATION

over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH} , t_{PHL}	Propagation delay	See Figure 1	22		51	ns
PWD	Pulse-width distortion ⁽¹⁾ $ t_{PHL} - t_{PLH} $				3	
t_{PLH} , t_{PHL}	Propagation delay		12		30	ns
PWD	Pulse-width distortion ⁽¹⁾ $ t_{PHL} - t_{PLH} $			1	2	
$t_{sk(pp)}$	Part-to-part skew ⁽²⁾	ISO724xC			10	ns
		ISO724xM		0	5	
$t_{sk(o)}$	Channel-to-channel output skew ⁽³⁾	ISO724xC			2.5	ns
		ISO724xM		0	1	
t_r	Output signal rise time	See Figure 1		2		ns
t_f	Output signal fall time			2		
t_{PHZ}	Propagation delay, high-level-to-high-impedance output	See Figure 2		15	20	ns
t_{PZH}	Propagation delay, high-impedance-to-high-level output			15	20	
t_{PLZ}	Propagation delay, low-level-to-high-impedance output			15	20	
t_{PZL}	Propagation delay, high-impedance-to-low-level output			15	20	
t_{fs}	Failsafe output delay time from input power loss	See Figure 3		12		μ s
t_{wake}	Wake time from input disable	See Figure 4		15		μ s
$t_{jit(pp)}$	Peak-to-peak eye-pattern jitter	ISO724xM		1		ns
		150 Mbps NRZ data input, Same polarity input on all channels, See Figure 6				

(1) Also known as pulse skew

(2) $t_{sk(pp)}$ is the magnitude of the difference in propagation delay times between any specified terminals of two devices when both devices operate with the same supply voltages, at the same temperature, and have identical packages and test circuits.

(3) $t_{sk(o)}$ is the skew between specified outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical specified loads.

ELECTRICAL CHARACTERISTICS: V_{CC1} and V_{CC2} at 3.3 V⁽¹⁾ OPERATION

over recommended operating conditions (unless otherwise noted)

PARAMETER			TEST CONDITIONS	MIN	TYP	MAX	UNIT
SUPPLY CURRENT							
I _{CC1}	ISO7240C/M	Quiescent	V _I = V _{CC} or 0 V, all channels, no load, EN ₂ at 3 V		0.5	1	mA
		25 Mbps			3	5	
	ISO7241C/M	Quiescent	V _I = V _{CC} or 0 V, all channels, no load, EN ₁ at 3 V, EN ₂ at 3 V		4	7	mA
		25 Mbps			6.5	11	
	ISO7242C/M	Quiescent	V _I = V _{CC} or 0 V, all channels, no load, EN ₁ at 3 V, EN ₂ at 3 V		6	10	
		25 Mbps			9	14	
I _{CC2}	ISO7240C/M	Quiescent	V _I = V _{CC} or 0 V, all channels, no load, EN ₂ at 3 V		9.5	15	mA
		25 Mbps			10.5	17	
	ISO7241C/M	Quiescent	V _I = V _{CC} or 0 V, all channels, no load, EN ₁ at 3 V, EN ₂ at 3 V		8	13	mA
		25 Mbps			11.5	18	
	ISO7242C/M	Quiescent	V _I = V _{CC} or 0 V, all channels, no load, EN ₁ at 3 V, EN ₂ at 3 V		6	10	
		25 Mbps			9	14	
ELECTRICAL CHARACTERISTICS							
I _{OFF}	Sleep mode output current		EN at 0 V, single channel		0		μA
V _{OH}	High-level output voltage		I _{OH} = −4 mA, See Figure 1	V _{CC} − 0.4			V
			I _{OH} = −20 μA, See Figure 1	V _{CC} − 0.1			
V _{OL}	Low-level output voltage		I _{OL} = 4 mA, See Figure 1	0.4			V
			I _{OL} = 20 μA, See Figure 1	0.1			
V _{I(HYS)}	Input voltage hysteresis			150			mV
I _{IH}	High-level input current		IN from 0 V or V _{CC}	10			μA
I _{IL}	Low-level input current			−10			
C _I	Input capacitance to ground		IN at V _{CC} , V _I = 0.4 sin (4E6πt)	2			pF
CMTI	Common-mode transient immunity		V _I = V _{CC} or 0 V, See Figure 5	25	50		kV/μs

- (1) For the 5-V operation, V_{CC1} or V_{CC2} is specified from 4.5 V to 5.5 V.
For the 3-V operation, V_{CC1} or V_{CC2} is specified from 3.15 V to 3.6 V.

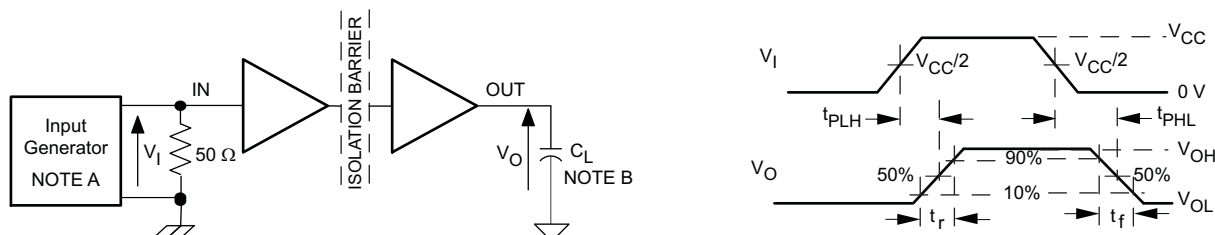
SWITCHING CHARACTERISTICS: V_{CC1} and V_{CC2} at 3.3-V OPERATION

over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH} , t_{PHL}	Propagation delay	See Figure 1	25		56	ns
PWD	Pulse-width distortion $ t_{PHL} - t_{PLH} ^{(1)}$				4	
t_{PLH} , t_{PHL}	Propagation delay		12		34	ns
PWD	Pulse-width distortion $ t_{PHL} - t_{PLH} ^{(1)}$			1	2	
$t_{sk(pp)}$	Part-to-part skew ⁽²⁾	ISO724xC			10	ns
		ISO724xM		0	5	
$t_{sk(o)}$	Channel-to-channel output skew ⁽³⁾	ISO724xC			3.5	ns
		ISO724xM		0	1	
t_r	Output signal rise time	See Figure 1		2		ns
t_f	Output signal fall time			2		ns
t_{PHZ}	Propagation delay, high-level-to-high-impedance output	See Figure 2		15	20	ns
t_{PZH}	Propagation delay, high-impedance-to-high-level output			15	20	
t_{PLZ}	Propagation delay, low-level-to-high-impedance output			15	20	
t_{PZL}	Propagation delay, high-impedance-to-low-level output			15	20	
t_{fs}	Failsafe output delay time from input power loss	See Figure 3		18		μ s
t_{wake}	Wake time from input disable	See Figure 4		15		μ s
$t_{jit(pp)}$	Peak-to-peak eye-pattern jitter	ISO724xM 150 Mbps PRBS NRZ data input, same polarity input on all channels, See Figure 6		1		ns

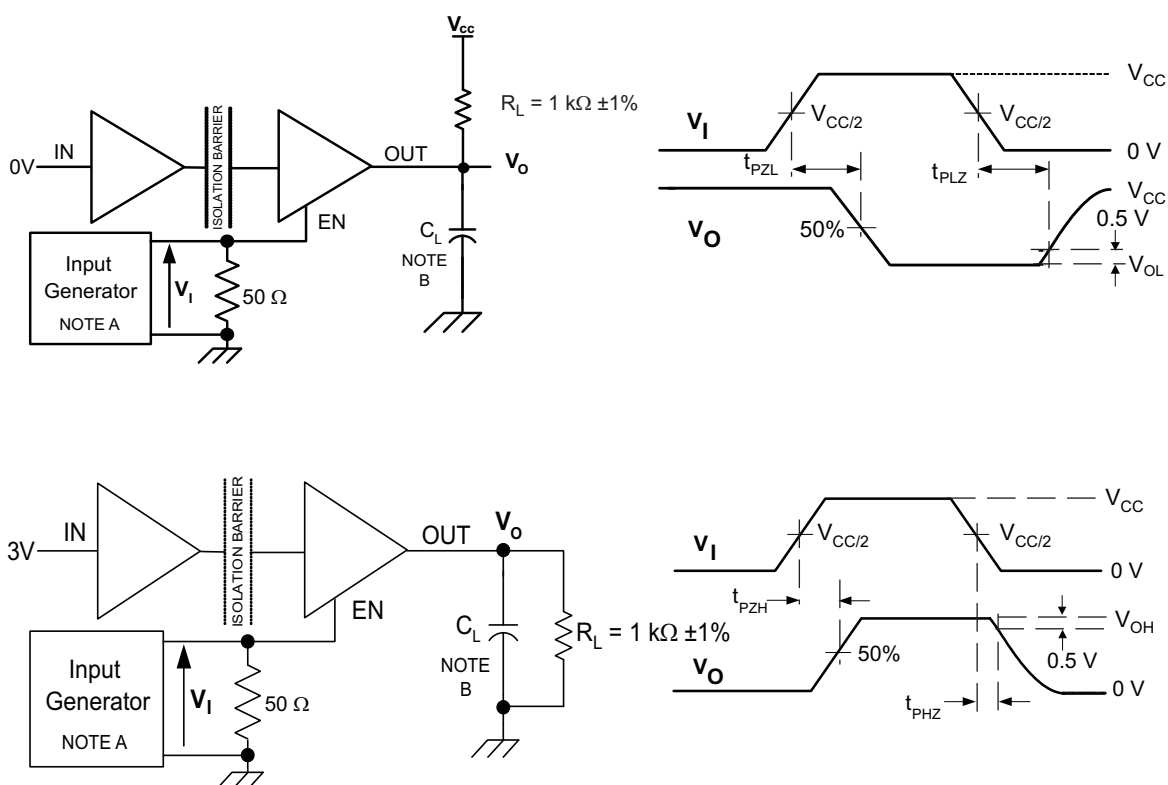
- (1) Also referred to as pulse skew.
- (2) $t_{sk(pp)}$ is the magnitude of the difference in propagation delay times between any specified terminals of two devices when both devices operate with the same supply voltages, at the same temperature, and have identical packages and test circuits.
- (3) $t_{sk(o)}$ is the skew between specified outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical specified loads.

PARAMETER MEASUREMENT INFORMATION



- The input pulse is supplied by a generator having the following characteristics: PRR $\leq$ 50 kHz, 50% duty cycle, $t_r \leq 3$ ns, $t_f \leq 3$ ns, $Z_O = 50 \Omega$.
- $C_L = 15$ pF and includes instrumentation and fixture capacitance within $\pm 20\%$.

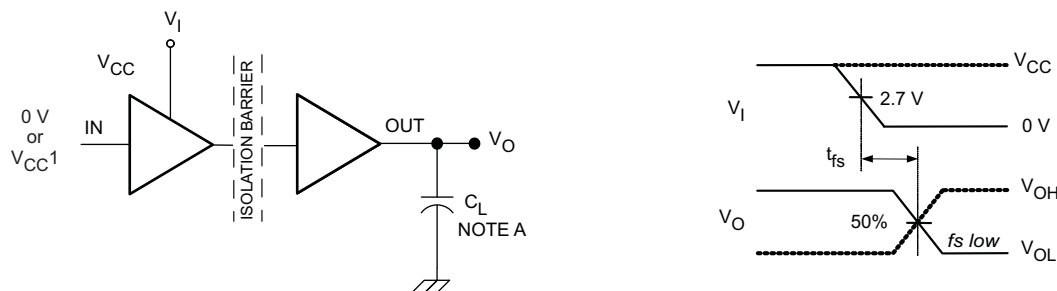
Figure 1. Switching Characteristic Test Circuit and Voltage Waveforms



- The input pulse is supplied by a generator having the following characteristics: PRR $\leq$ 50 kHz, 50% duty cycle, $t_r \leq 3$ ns, $t_f \leq 3$ ns, $Z_O = 50 \Omega$.
- $C_L = 15$ pF and includes instrumentation and fixture capacitance within $\pm 20\%$.

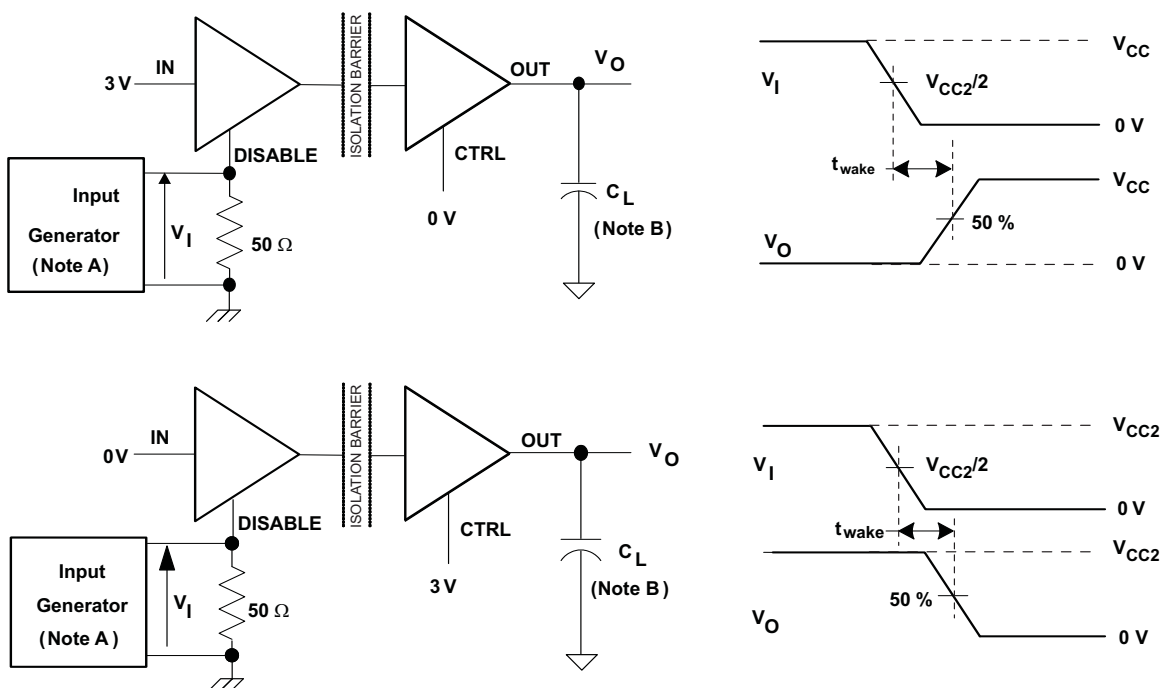
Figure 2. Enable/Disable Propagation Delay Time Test Circuit and Waveform

PARAMETER MEASUREMENT INFORMATION (continued)



A. $C_L = 15$ pF and includes instrumentation and fixture capacitance within $\pm 20\%$.

Figure 3. Failsafe Delay Time Test Circuit and Voltage Waveforms

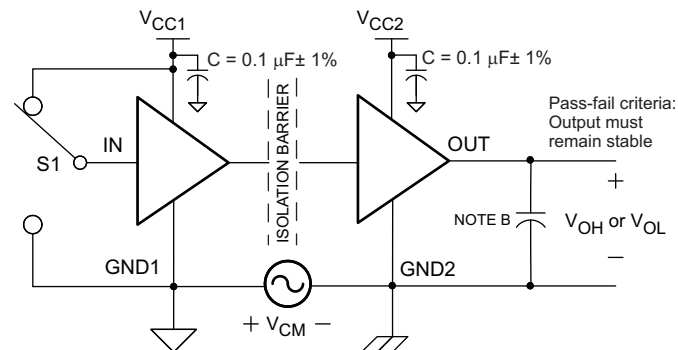


NOTE: Which ever test yields the longest time is used in this data sheet

- A. The input pulse is supplied by a generator having the following characteristics: PRR ≤ 50 kHz, 50% duty cycle, $t_r \leq 3$ ns, $t_f \leq 3$ ns, $Z_O = 50\Omega$.
- B. $C_L = 15$ pF and includes instrumentation and fixture capacitance within $\pm 20\%$.

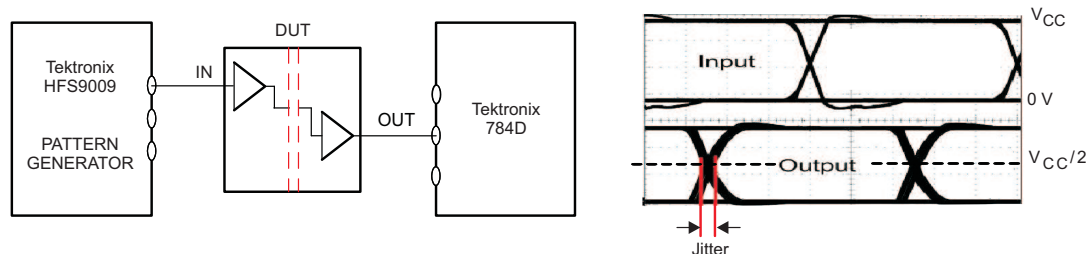
Figure 4. Wake Time From Input Disable Test Circuit and Voltage Waveforms

PARAMETER MEASUREMENT INFORMATION (continued)



- A. $C_L = 15$ pF and includes instrumentation and fixture capacitance within $\pm 20\%$.
- B. The input pulse is supplied by a generator having the following characteristics: $PRR \leq 50$ kHz, 50% duty cycle, $t_r \leq 3$ ns, $t_f \leq 3$ ns, $Z_0 = 50\Omega$.

Figure 5. Common-Mode Transient Immunity Test Circuit and Voltage Waveform



NOTE: PRBS bit pattern run length is $2^{16} - 1$. Transition time is 800 ps. NRZ data input has no more than five consecutive 1s or 0s.

Figure 6. Peak-to-Peak Eye-Pattern Jitter Test Circuit and Voltage Waveform

DEVICE INFORMATION

PACKAGE CHARACTERISTICS

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
L(I01)	Minimum air gap (Clearance)	Shortest terminal-to-terminal distance through air	8.34			mm
L(I02)	Minimum external tracking (Creepage)	Shortest terminal-to-terminal distance across the package surface	8.1			mm
C _{TI}	Tracking resistance (comparative tracking index)	DIN IEC 60112/VDE 0303 Part 1	≥ 175			V
	Minimum Internal Gap (Internal Clearance)	Distance through the insulation	0.008			mm
R _{IO}	Isolation resistance	Input to output, V _{IO} = 500 V, all pins on each side of the barrier tied together creating a two-terminal device	>10 ¹²			Ω
C _{IO}	Barrier capacitance Input to output	V _I = 0.4 sin (4E6πt)		2		pF
C _I	Input capacitance to ground	V _I = 0.4 sin (4E6πt)		2		pF

IEC 60664-1 RATINGS TABLE

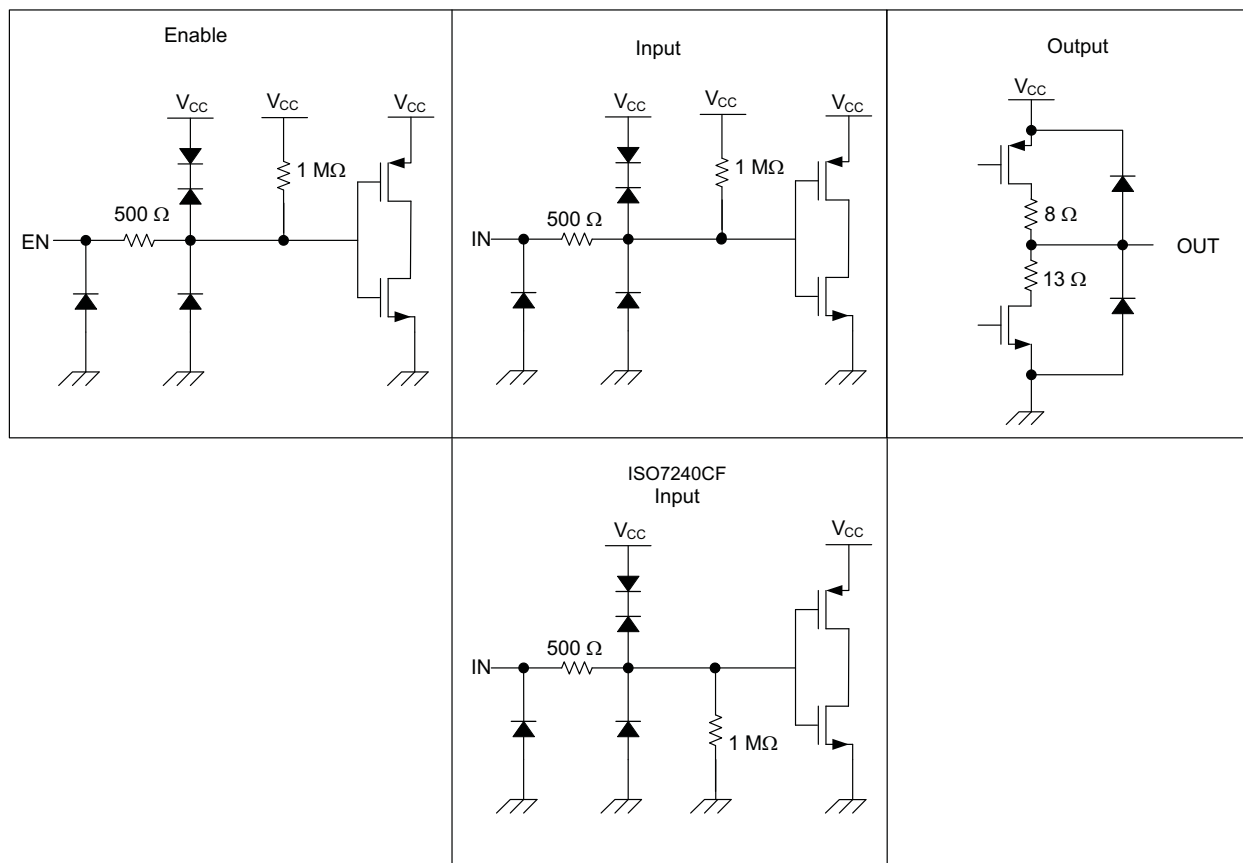
PARAMETER	TEST CONDITIONS	SPECIFICATION
Basic isolation group	Material group	IIIa
Installation classification	Rated mains voltage ≤150 VRMS	I-IV
	Rated mains voltage ≤300 VRMS	I-III

REGULATORY INFORMATION

VDE	CSA	UL
Certified according to IEC 60747-5-2	Approved under CSA Component Acceptance Notice	Recognized under 1577 Component Recognition Program ⁽¹⁾
File Number: 40016131	File Number: 220991	File Number: E181974

(1) Production tested ≥ 3000 Vrms for 1 second in accordance with UL 1577.

DEVICE I/O SCHEMATICS



THERMAL CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
θ_{JA} Junction-to-air	Low-K Thermal Resistance ⁽¹⁾		168		°C/W
	High-K Thermal Resistance		96.1		
θ_{JB} Junction-to-Board Thermal Resistance			61		°C/W
θ_{JC} Junction-to-Case Thermal Resistance			48		°C/W
P_D Device Power Dissipation	$V_{CC1} = V_{CC2} = 5.5\text{ V}$, $T_J = 150^\circ\text{C}$, $C_L = 15\text{ pF}$, Input a 50% duty cycle square wave			220	mW

(1) Tested in accordance with the Low-K or High-K thermal metric definitions of EIA/JESD51-3 for leaded surface mount packages.

TYPICAL CHARACTERISTIC CURVES

ISO7240C/M RMS SUPPLY CURRENT

VS

SIGNALING RATE

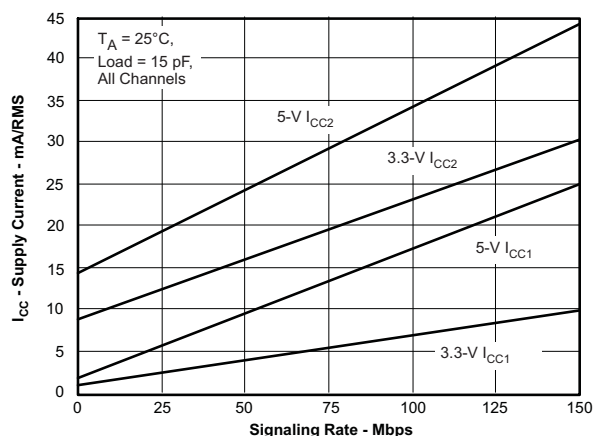


Figure 7.

ISO7241C/M RMS SUPPLY CURRENT

VS

SIGNALING RATE

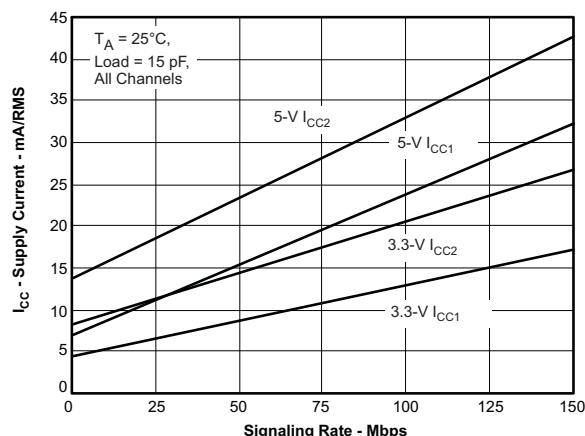


Figure 8.

ISO7242C/M RMS SUPPLY CURRENT

VS

SIGNALING RATE

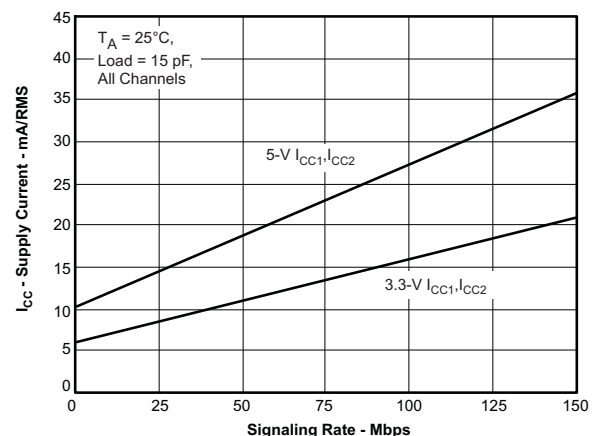


Figure 9.

PROPAGATION DELAY

VS

FREE-AIR TEMPERATURE

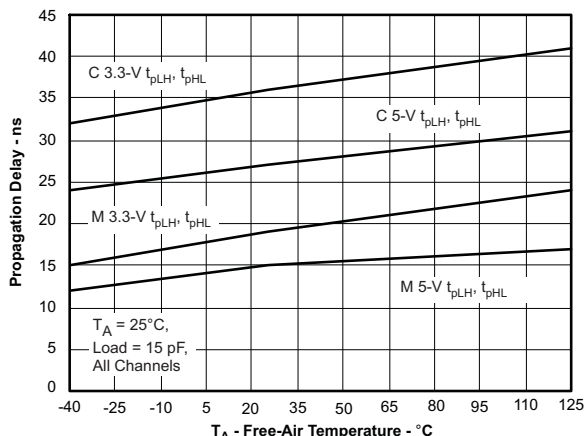


Figure 10.

TYPICAL CHARACTERISTIC CURVES (continued)

**INPUT VOLTAGE THRESHOLD
VS
FREE-AIR TEMPERATURE**

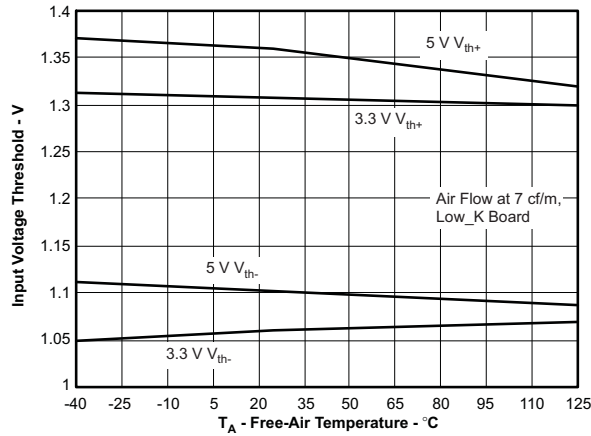


Figure 11.

**V_{CC1} FAILSAFE THRESHOLD
VS
FREE-AIR TEMPERATURE**

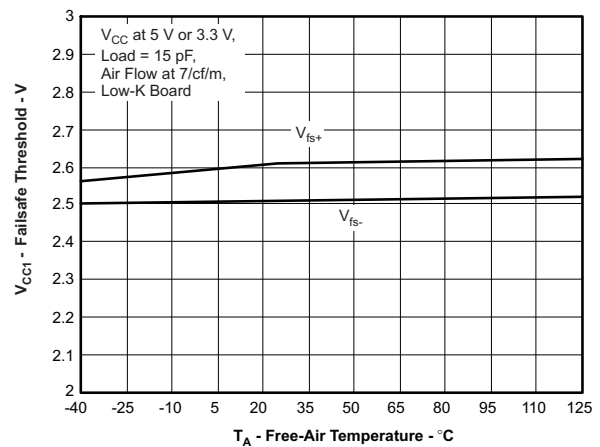


Figure 12.

**HIGH-LEVEL OUTPUT CURRENT
VS
HIGH-LEVEL OUTPUT VOLTAGE**

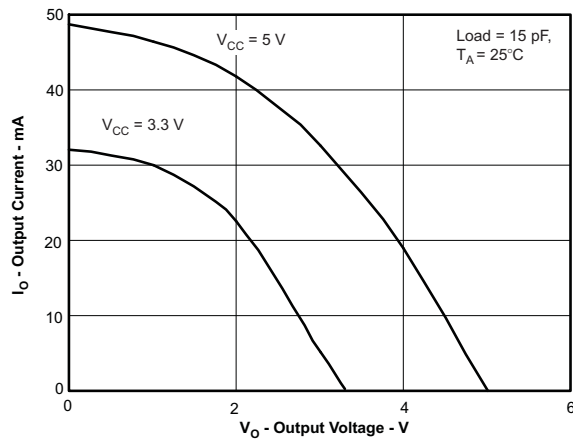


Figure 13.

**LOW-LEVEL OUTPUT CURRENT
VS
LOW-LEVEL OUTPUT VOLTAGE**

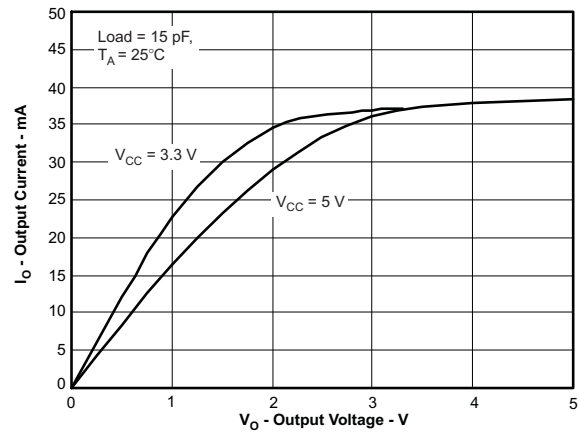


Figure 14.

APPLICATION INFORMATION

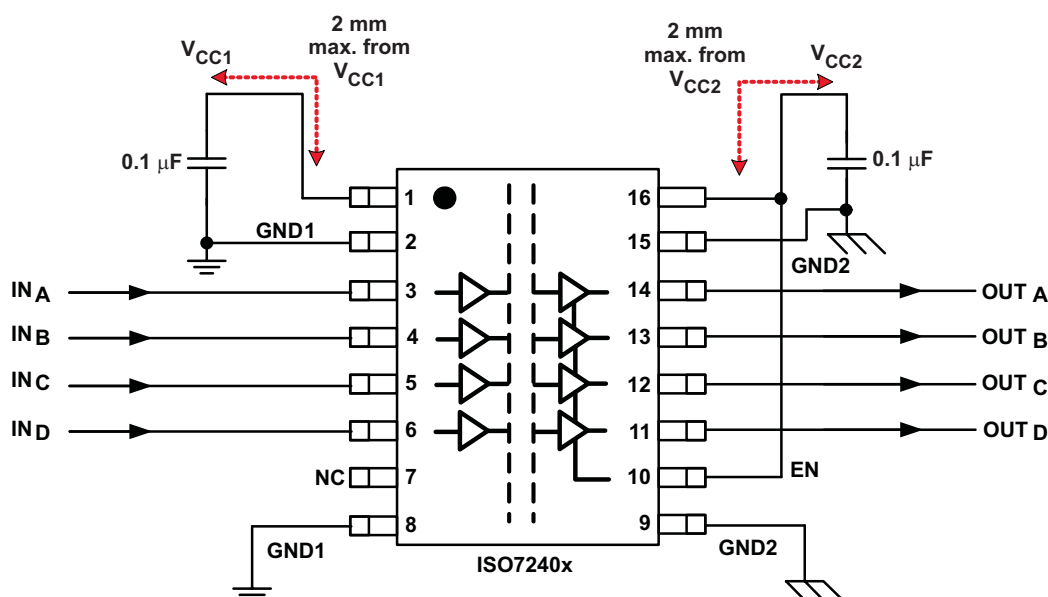


Figure 15. Typical ISO7240x Application Circuit

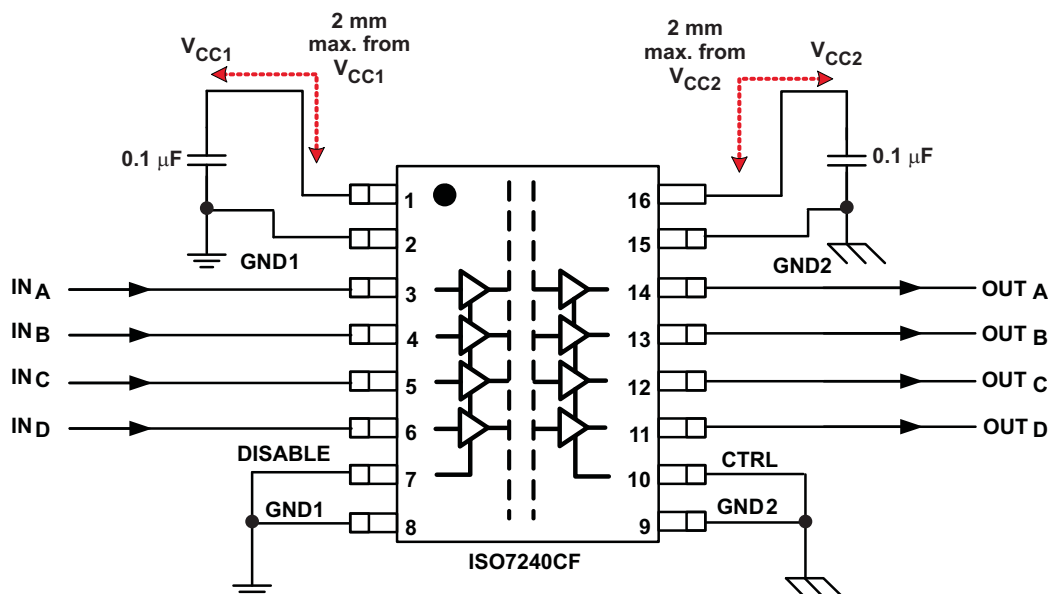


Figure 16. Typical ISO7240CF Failsafe-Low Application Circuit

LIFE EXPECTANCY vs. WORKING VOLTAGE

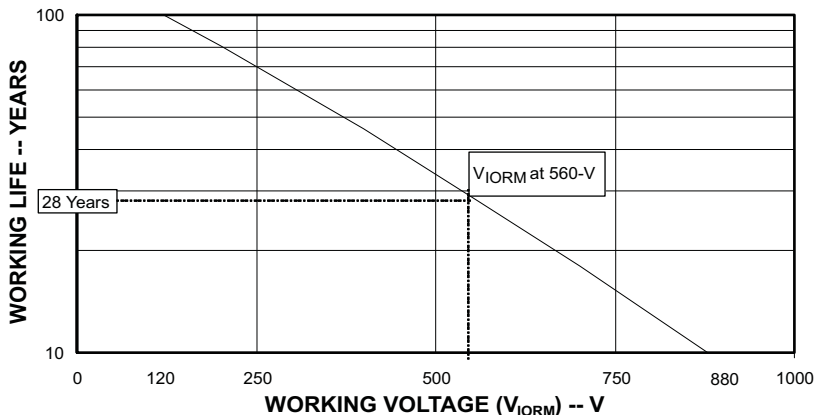


Figure 17. Time-Dependant Dielectric Breakdown Testing Results

REVISION HISTORY

Changes from Original (September 2007) to Revision A	Page
Deleted Product Preview note	2
Changed V_{CC} Supply Voltage in the ROC Table From: 3.6 To: 3.45	3
Changed V_{CC} Supply Voltage in the ROC Table From: 3 To: 3.15	3
Changed TBDs to actual values.	4
Changed C_1 - typ value From: 1 To: 2	4
Changed Propagation delay max From: 22 To: 23	5
Changed C_1 - typ value From: 1 To: 2	6
Changed Propagation delay max From: 46 To: 50	7
Changed Propagation delay max From: 28 To: 29	7
Changed ISO724xA/C max value From: 2.5 To: 3	7
Changed C_1 - typ value From: 1 To: 2	8
Changed Propagation delay max From: 26 To: 30	9
Changed typ value From: 1 To: 2	10
Changed Propagation delay max From: 32 To: 34	11
Changed ISO724xA/C max value From: 3 To: 3.5	11
Changed C_{IO} - typ value From: 1 To: 2	14
Changed C_1 - typ value From: 1 To: 2	14
Changed the REGULATORY INFORMATION Table	15
Changed Figure 7 , Figure 8 , and Figure 10 . Added Figure 9	16

Changes from Revision A (December 2007) to Revision B	Page
Changed V_{CC} Supply Voltage in the ROC Table From: 3.45 To: 3.6	3

Changes from Revision B (August 2008) to Revision C	Page
Deleted Min = 4.5 V and max = 5.5 V for Supply Voltage of the ROC Table.	3
Changed V_{CC} Supply Voltage in the ROC Table From: 3.6 To: 5.5	3

Changes from Revision C (April 2008) to Revision D

Page

• Changed Feature Bullet 4000- V_{peak} Isolation	1
• Added $t_{sk(pp)}$ Part-to-part skew	5
• Added $t_{sk(pp)}$ Part-to-part skew	7
• Added $t_{sk(pp)}$ Part-to-part skew	9
• Added $t_{sk(pp)}$ Part-to-part skew	11
• Changed Typical ISO724x Application Circuit Figure 15	18

Changes from Revision D (April 2008) to Revision E

Page

• Added table note: or the 5-V operation, V_{CC1} or V_{CC2} is specified from 4.5 V to 5.5 V.	3
• Added table note: or the 5-V operation, V_{CC1} or V_{CC2} is specified from 4.5 V to 5.5 V	4
• Added table note: or the 5-V operation, V_{CC1} or V_{CC2} is specified from 4.5 V to 5.5 V	6
• Added table note: or the 5-V operation, V_{CC1} or V_{CC2} is specified from 4.5 V to 5.5 V	8
• Added table note: or the 5-V operation, V_{CC1} or V_{CC2} is specified from 4.5 V to 5.5 V	10

Changes from Revision E (May 2008) to Revision F

Page

• Changed Title From: QUAD DIGITAL ISOLATORS To: HIGH SPEED QUAD DIGITAL ISOLATORS	1
• Deleted ISO724xA devices. See SLLS905 for the ISO7240A, ISO7241A, and ISO7242A.	1
• Changed Feature Low Jitter Content - From: 1, 25, and 150-Mbps Signaling Rate Options To: 25, and 150-Mbps Signaling Rate Options	1
• Added $t_{sk(pp)}$ footnote.	5
• Added $t_{sk(o)}$ footnote.	5
• Added $t_{sk(pp)}$ footnote.	11
• Added $t_{sk(o)}$ footnote.	11

Changes from Revision F (May 2008) to Revision G

Page

• Changed the PACKAGE CHARACTERISTICS table, line , $L_{(IO1)}$ MIN value from 7.7mm to 8.34mm	14
--	----

Changes from Revision G (July 2008) to Revision H

Page

• Added Device number ISO7240CF.	1
• Added Features Bullet: Selectable Failsafe Output (ISO7240CF)	1
• Changed description paragraph 4 text.	1
• Added for device number ISO7240CF.	2
• Changed V_I in the Abs Max Table From: Voltage at IN, OUT, EN To: Voltage at IN, OUT, EN, DISABLE, CTRL	3
• Added t_{wake} , Wake time from input disable	5
• Added t_{wake} , Wake time from input disable	7
• Added t_{wake} , Wake time from input disable	9
• Added t_{wake} , Wake time from input disable	11

Changes from Revision H (October 2008) to Revision I

Page

• Added information to the Features bullet to include CSA and IEC 60950-1 certification	1
---	---

Changes from Revision I (December 2008) to Revision J **Page**

- Changed I_{CC1} for Quiescent and 1Mbps From: 10mA To: 11mA [4](#)
 - Changed I_{CC1} for Quiescent and 1Mbps From: 10mA To: 11mA [6](#)
-

Changes from Revision J (April 2009) to Revision K **Page**

- Changed the Input circuit in the DEVICE I/O SCHEMATICS illustration [15](#)
-

Changes from Revision K (December 2009) to Revision L **Page**

- Added the IEC 60747-5-2 INSULATION CHARACTERISTIC table [3](#)
 - Added C_{TI} - Tracking resistance (comparative tracking index) to the PACKAGE CHARACTERISTICS table [14](#)
 - Added the IEC 60664-1 RATINGS TABLE [14](#)
-

Changes from Revision L (January 2010) to Revision M **Page**

- Changed [Figure 1](#), [Figure 3](#), and [Figure 4](#) [12](#)
 - Changed the CSA File Number From: 1698195 To: 220991 [15](#)
-

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/ Ball Finish	MSL Peak Temp ⁽³⁾	Samples (Requires Login)
ISO7240CDW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7240CDWG4	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7240CDWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7240CDWRG4	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7240CFDW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7240CFDWG4	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7240CFDWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7240CFDWRG4	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7240MDW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7240MDWG4	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7240MDWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7240MDWRG4	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7241CDW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7241CDWG4	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7241CDWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7241CDWRG4	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7241MDW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/ Ball Finish	MSL Peak Temp ⁽³⁾	Samples (Requires Login)
ISO7241MDWG4	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7241MDWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7241MDWRG4	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7242CDW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7242CDWG4	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7242CDWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7242CDWRG4	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7242MDW	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7242MDWG4	ACTIVE	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7242MDWR	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart
ISO7242MDWRG4	ACTIVE	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	Add to cart

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

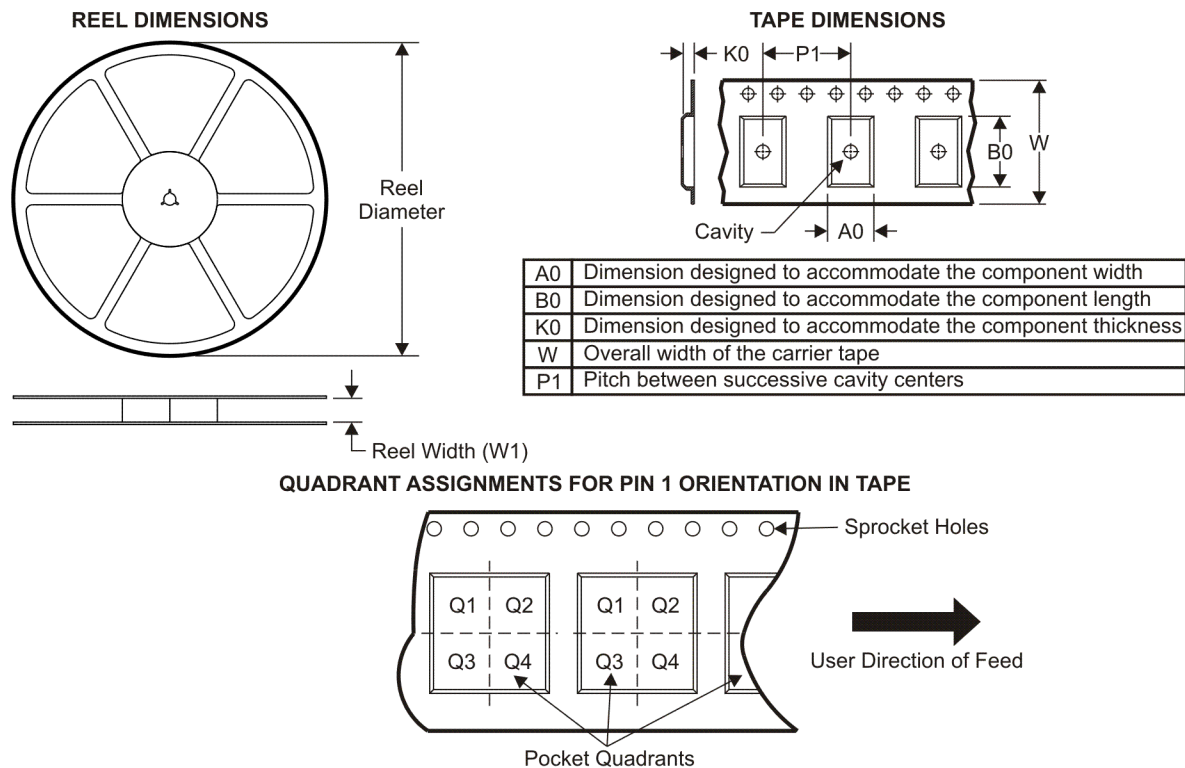
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF ISO7240CF, ISO7241C :

- Automotive: [ISO7240CF-Q1](#), [ISO7241C-Q1](#)

NOTE: Qualified Version Definitions:

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

TAPE AND REEL INFORMATION


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ISO7240CDWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
ISO7240CFDWR	SOIC	DW	16	2000	330.0	16.4	10.9	10.78	3.0	12.0	16.0	Q1
ISO7240MDWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
ISO7241CDWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
ISO7241MDWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
ISO7242CDWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
ISO7242MDWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1

TAPE AND REEL BOX DIMENSIONS

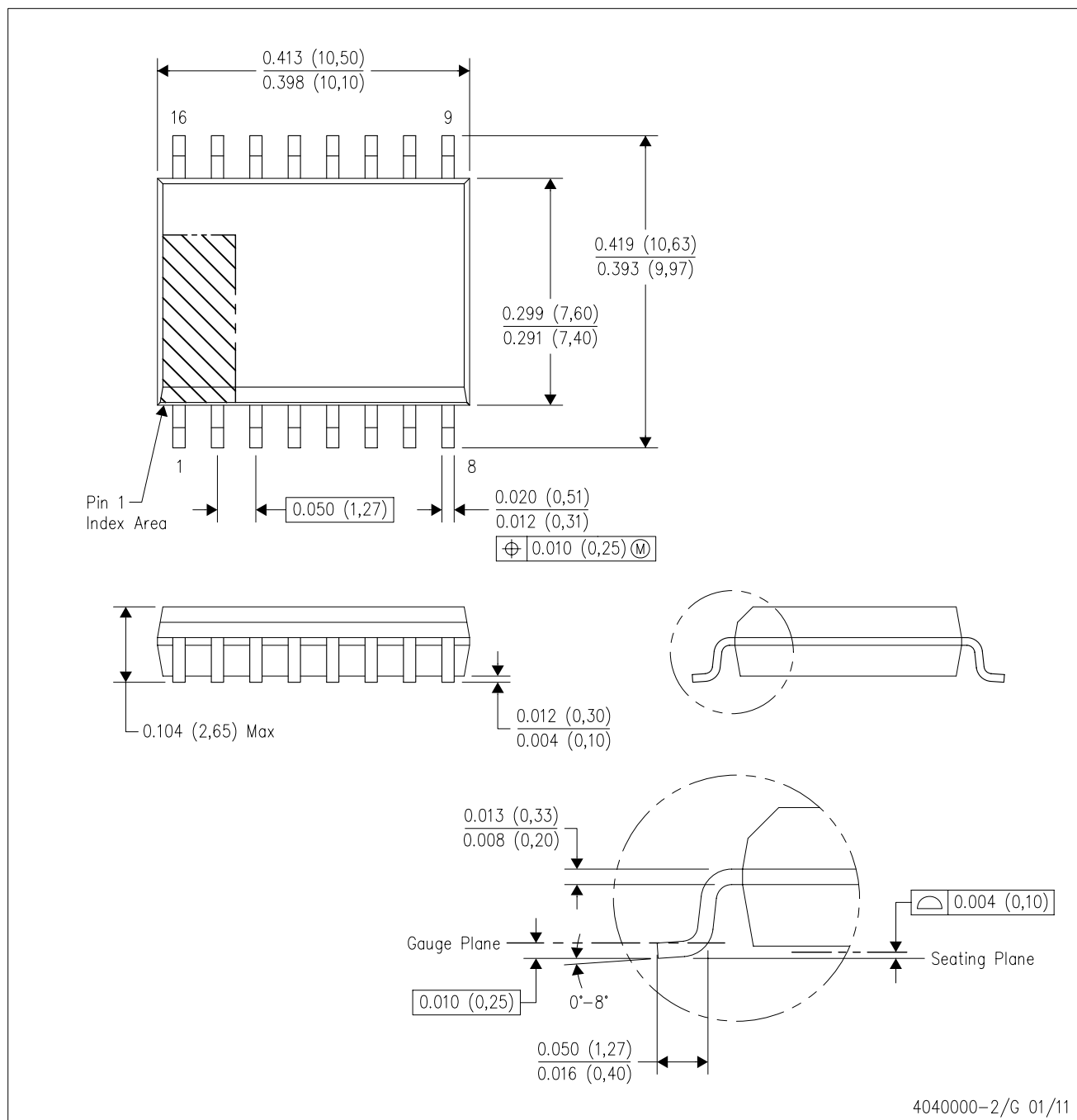


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ISO7240CDWR	SOIC	DW	16	2000	358.0	335.0	35.0
ISO7240CFDWR	SOIC	DW	16	2000	358.0	335.0	35.0
ISO7240MDWR	SOIC	DW	16	2000	358.0	335.0	35.0
ISO7241CDWR	SOIC	DW	16	2000	358.0	335.0	35.0
ISO7241MDWR	SOIC	DW	16	2000	358.0	335.0	35.0
ISO7242CDWR	SOIC	DW	16	2000	358.0	335.0	35.0
ISO7242MDWR	SOIC	DW	16	2000	358.0	335.0	35.0

DW (R-PDSO-G16)

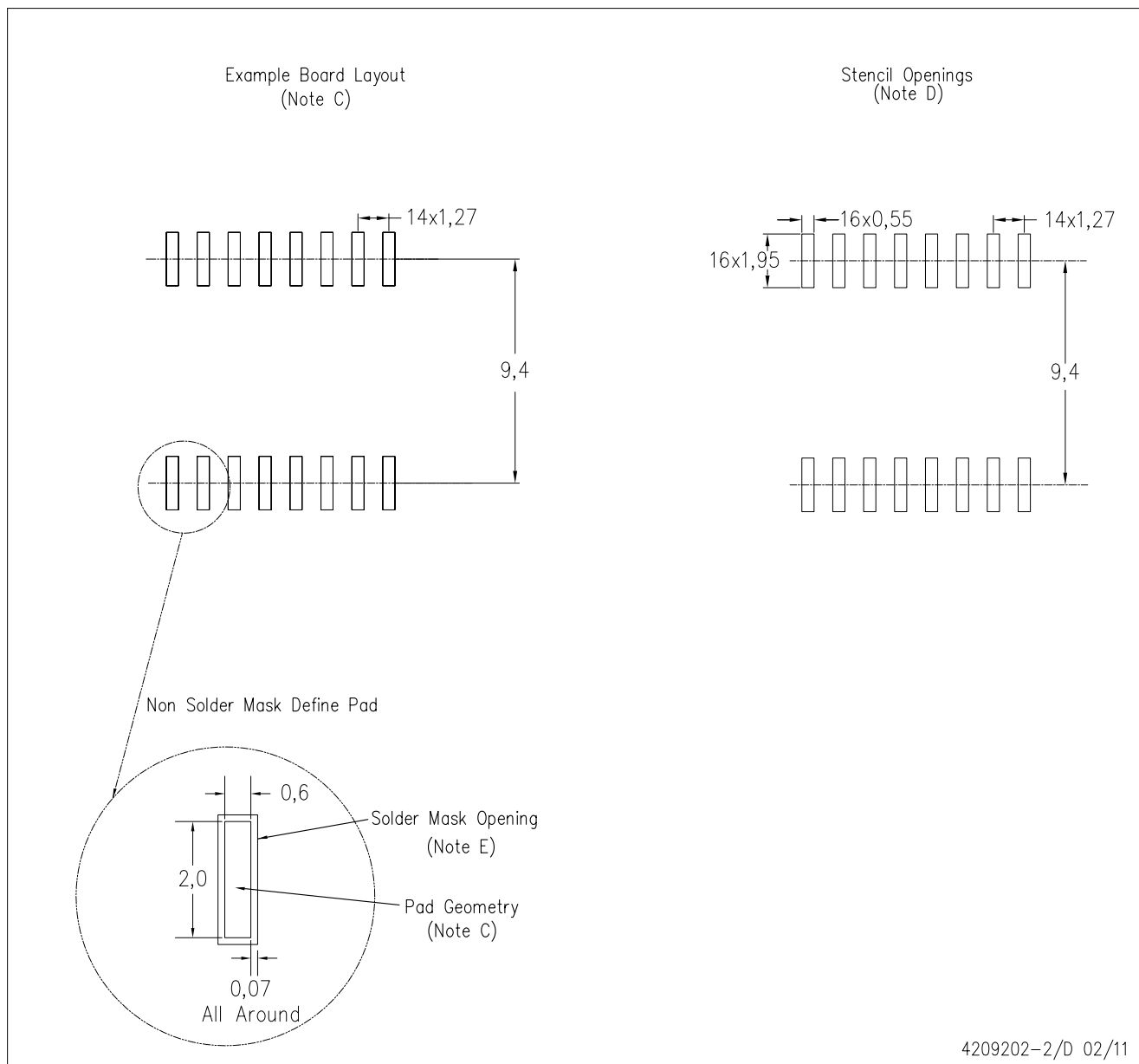
PLASTIC SMALL OUTLINE



- NOTES:
- All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.
 - This drawing is subject to change without notice.
 - Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
 - Falls within JEDEC MS-013 variation AA.

DW (R-PDSO-G16)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Refer to IPC7351 for alternate board design.
 - D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525
 - E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

TI products are not authorized for use in safety-critical applications (such as life support) where a failure of the TI product would reasonably be expected to cause severe personal injury or death, unless officers of the parties have executed an agreement specifically governing such use. Buyers represent that they have all necessary expertise in the safety and regulatory ramifications of their applications, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of TI products in such safety-critical applications, notwithstanding any applications-related information or support that may be provided by TI. Further, Buyers must fully indemnify TI and its representatives against any damages arising out of the use of TI products in such safety-critical applications.

TI products are neither designed nor intended for use in military/aerospace applications or environments unless the TI products are specifically designated by TI as military-grade or "enhanced plastic." Only products designated by TI as military-grade meet military specifications. Buyers acknowledge and agree that any such use of TI products which TI has not designated as military-grade is solely at the Buyer's risk, and that they are solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI products are neither designed nor intended for use in automotive applications or environments unless the specific TI products are designated by TI as compliant with ISO/TS 16949 requirements. Buyers acknowledge and agree that, if they use any non-designated products in automotive applications, TI will not be responsible for any failure to meet such requirements.

Following are URLs where you can obtain information on other Texas Instruments products and application solutions:

Products

Audio	www.ti.com/audio
Amplifiers	amplifier.ti.com
Data Converters	dataconverter.ti.com
DLP® Products	www.dlp.com
DSP	dsp.ti.com
Clocks and Timers	www.ti.com/clocks
Interface	interface.ti.com
Logic	logic.ti.com
Power Mgmt	power.ti.com
Microcontrollers	microcontroller.ti.com
RFID	www.ti-rfid.com
RF/IF and ZigBee® Solutions	www.ti.com/lprf

Applications

Communications and Telecom	www.ti.com/communications
Computers and Peripherals	www.ti.com/computers
Consumer Electronics	www.ti.com/consumer-apps
Energy and Lighting	www.ti.com/energy
Industrial	www.ti.com/industrial
Medical	www.ti.com/medical
Security	www.ti.com/security
Space, Avionics and Defense	www.ti.com/space-avionics-defense
Transportation and Automotive	www.ti.com/automotive
Video and Imaging	www.ti.com/video
Wireless	www.ti.com/wireless-apps

TI E2E Community Home Page

e2e.ti.com

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265
Copyright © 2011, Texas Instruments Incorporated